Brammer Standard Company, Inc.

Certificate of Analysis

BS CD4MCU-A

Certified Reference Material for High Alloy Steel - UNS Number J93370

	Certified Value ¹	Estimate of Uncertainty ²	Certified Values ³		Certified Value ¹	Estimate of Uncertainty ²
As	0.0022	0.0005		N	0.0112	0.0009
C	0.021	0.001		Ni	5.18	0.06
Cr	24.6	0.2		0	0.0061	0.0006
Cu	2.92	0.04		S	0.0072	0.0009
Fe	64.5	0.2		Si	0.31	0.01
Mn	0.38	0.02		Sn	0.0024	0.0004
Мо	1.92	0.04		Ti	0.021	0.002

Informational Values^{3,4}

AI (0.009)	B (0.0008)	Ca (0.001)	Co (0.005)	Mg (0.0003)
Nb (0.009)	P (0.008)	Pb (0.002)	Sb (0.0007)	V (0.006)
W (0.009)	Zr (0.002)			

For each element, the certified value listed is the present best estimate of the true value based on the mean of the weighted results of an interlaboratory testing program. See page 3 for more information on its calculation.

Trace element information values for Ag, Cl, Ga, Ge, In, Na, Re, Ru, Sb, Se, Sr, Ta, Y, and Zn are shown on page 3.

The requirements of ISO Guides 30, 31, and 35 were followed for the preparation of this Certified Reference Material and certificate of analysis.

² For each element, the uncertainty listed is based on a statistical evaluation of the contributions of homogeneity and the interlaboratory testing program. See page 3 for more information on its calculation.

³ Values are given in weight percent. Values in brackets are reported by difference.

⁴ Values in parentheses are not certified and are provided for information only.

BS CD4MCU-A * Code for method Certified values listed as weight percent

Analysis	*	As	*	С	*	Cr	*	Cu	*	Fe	*	Mn	*	Mo	*	N	*	Ni	*	0
1	11	0.0019	1	0.01883333	10	24.45	10	2.864	14	64.2666667	3	0.348	3	1.84	2	0.00966667	10	5.09	2	0.0046
2	5	0.00193	3	0.0195	4	24.47167	4	2.873333	16	[64.36]	5	0.3556667	4	1.85767	2	0.01013333	4	5.107333	2	0.0053
3	5	0.00208	1	0.0196	3	24.50	4	2.880833	16	[64.374067]	4	0.3597	4	1.8691	2	0.0104	4	5.133333	2	0.0056
4	4	0.0022	1	0.01986667	10	24.588	4	2.894133	16	[64.4]	4	0.3619333	4	1.88333	2	0.0109	3	5.1433	2	0.00565
5	4	0.0022	1	0.0205	13	24.648	10	2.90	11	64.47	4	0.37	10	1.89	2	0.01163333	10	5.154	1	0.0057
6	15	0.00222	11	0.0206	11	24.66	3	2.9	13	64.4726667	8	0.376	4	1.89733	2	0.01166667	4	5.156667	2	0.00582
7	5	0.0024	1	0.02066667	4	24.67533	4	2.905667	4	64.5733333	4	0.3766667	3	1.9133	2	0.0119	4	5.166	2	0.006
8	12	0.00263	1	0.021	3	24.677	4	2.907	4	64.7	4	0.3793333	4	1.917	2	0.0120	13	5.175333	2	0.0065
9			3	0.0213	4	24.7	4	2.9200	16	[64.7323]	4	0.3796667	10	1.927	2	0.01216667	11	5.18	2	0.0077
10			1	0.02146667	4	24.74	4	2.927333	16	[64.7434]	4	0.3822	4	1.93757	2	0.01218	4	5.183	2	0.0079
11			1	0.02146667	14	24.76667	4	2.949667			11	0.383	11	1.94			14	5.186667		
12			1	0.02146667	4	24.79897	3	2.9573			3	0.39	3	1.94			4	5.221833		
13			1	0.0217	4	24.85333	11	2.96			4	0.3990	14	1.95			3	5.24		
14					3	24.86	4	2.99			10	0.40					3	5.29		
15							14	2.993333			14	0.406					4	5.30		
16																	4	5.329333		
Average		0.00218		0.02094		24.641		2.921507		64.528		0.3831		1.9211		0.01115		5.1800		0.00608
Std Dev		0.00020		0.00083		0.043		0.000082		0.061		0.0047		0.0081		0.00047		0.0075		0.00010
н		0.00052		0.0014		0.085		0.020		0.17		0.0060		0.015		0.0010		0.029		0.00079
U ₁		0.00056		0.0016		0.095		0.020		0.18		0.0076		0.017		0.0011		0.030		0.00079
t-statistic		2.36		2.18		2.16		2.14		2.26		2.14		2.18		2.26		2.13		2.26
U ₂		0.0013		0.0035		0.20		0.043		0.41		0.016		0.038		0.0025		0.064		0.0018
U ₃		0.00047		0.0010		0.055		0.011		0.13		0.0042		0.011		0.00080		0.016		0.00057
Certified		0.0022		0.021		24.6		2.92		64.5		0.38		1.92		0.0112		5.18		0.0061
Uncertainty		0.0005		0.001		0.2		0.04		0.2		0.02		0.04		0.0009		0.06		0.0006
Tolerance		0.0013		0.003		0.6		0.12		0.6		0.06		0.16		0.0027		0.18		0.0018

Analysis	*	S	*	Si	*	Sn	*	Ti	
1	1	0.0059	4	0.29	3	0.002	12	0.015333	
2	3	0.0061	3	0.298	9	0.002067	4		
3	1	0.00647	6	0.30616667	4	0.002133	3	0.0188	
4	10	0.0066	10			0.002233	_	0.020067	
5	1	0.0069	4	0.311		0.002333		0.020133	
6	1	0.00697	4	0.31136667	12	0.002367	11		
7	3	0.007		0.31166667		0.002367	14	0.020833	
8	1	0.00727	6	0.315	5	0.0025	10		
9	1	0.00733	4	0.317	3	0.0025	4	0.021233	
10	1	0.0079	4	0.31833333	5	0.002527	4	0.0213	
11	1	0.008	11	0.32	4	0.002633	5	0.0219	
12	1	0.00807	3	0.3208			4	0.022133	
13	1	0.00853	4	0.3283			4	0.022467	
14	11	0.0091	4	0.33766667			7	0.023367	
15							4	0.023833	
16							3	0.024	
Average		0.00719		0.313950		0.00241		0.02087	
Std Dev		0.00029		0.000085		0.00011		0.00087	
Н		0.00084		0.00534653		0.00054		0.001351	
U ₁		0.00089		0.0053		0.00055		0.0016	
t-statistic		2.16		2.16		2.23		2.13	
U ₂		0.0019		0.012		0.0012		0.0034	
U ₃		0.00052		0.0031		0.00037		0.00086	
Certified		0.0072		0.31		0.0024		0.021	
Uncertainty		0.0009		0.01		0.0004		0.002	
Tolerance		0.0027		0.03		0.0012		0.006	

Analysis	*	Al	*	В	*	Ca	*	Co	*	Mg	*	Nb	*	P	*	Pb	*	V	*	W	,	t Zr	r
1	12	0.00547	12	0.0000663	4	0.0001	5	0.001133	4	0.00021667	4	0.0006	3	0.0001	12	0.0000057	4	0.0026	12	0.00013		5 0.000	014
2	14	0.00647	4	0.0002	3	0.00036	3	0.0014	4	0.00023333	12	0.0031667	11	0.0024	9	0.0002	12	0.003733	5	0.00015	4	4 0.000	057
3	5	0.0067	7	0.00024667	4	0.002433	4	0.002967	4	0.00035333	5	0.0034933	12	0.00267	3	0.0002	5	0.004333	4	0.00177	3	0.00)08
4	5	0.00773	3	0.0004			4	0.0031	3	0.00036	5	0.0035333	7	0.003	5	0.0002	4	0.0044	4	0.0068	4	4 0.000	093
5	4	0.00977	11	0.0007			5	0.00326			5	0.004	5	0.00567	4	0.0006	4	0.004893	11	0.0078	3	0.00)12
6	3	0.010	4	0.0007			12	0.003933			4	0.0082	14	0.00573	3	0.0029	4	0.006133	14	0.00813	4	4 0.00	183
7	4	0.0101	3	0.0007			3	0.0040			11	0.0102	4	0.00577	4	0.00923333	4	0.0064	4	0.00867	4	4 0.00)23
8	3	0.0102	4	0.00176667			4	0.0040			3	0.0112	3	0.006			3	0.007	3	0.0097	3	0.00)33
9	11	0.0102	14	0.00263333			11	0.0043			14	0.0122	10	0.0061			10	0.008	4	0.00997	1	2 0.003	377
10	4	0.0102					4	0.0099			4	0.0138667	5	0.00617			4	0.008233	3	0.0407			
11	4	0.0104					14	0.012667			3	0.0232	3	0.0062			14	0.008267					
12	3	0.0110											4	0.0070			3	0.0125					
13													4	0.04247			3	0.0125					
Average		0.009		0.0008		0.0010		0.005		0.00029		0.009		0.008		0.0019		0.005818		0.009		0.00)16
Std Dev		0.058		0.0017		0.0040		0.025		0.00032		0.056		0.045		0.0084		0.000095		0.066		0.00)58
н		0.001		0.0004		0.0004		0.001		0.00026		0.001		0.001		0.0005		0.00077		0.001		0.00)05
U ₁		0.058		0.0018		0.0040		0.025		0.00041		0.056		0.045		0.0084		0.00078		0.066		0.00)58
t-statistic		2.20		2.31		4.30		2.23		3.18		2.23		2.18		2.45		2.18		2.26		2.3	31
U ₂		0.13		0.0040		0.017		0.056		0.0013		0.13		0.10		0.021		0.0017		0.15		0.0	13
U ₃		0.037		0.0013		0.0099		0.017		0.00066		0.038		0.027		0.0078		0.00047		0.047		0.00)45
Informationa	I	(0.009)		(8000.0)		(0.001)		(0.005)		(0.0003)		(0.009)		(0.008)		(0.002)		(0.006)		(0.009)		(0.0	02)

For each element, in accordance with the requirements of ISO 17034 and Guide 35, an effort must be made to account for the effects on the certified value of the uncertainty estimate from homogeneity testing (H) and the uncertainties of the contributing laboratories. The average (A) is calculated using a weighted mean where the reciprocal of the square of each laboratory's combined uncertainty (C_L), calculated from its standard deviation (S_L) and its uncertainty estimate (U_L), is used as the weight (W_L) for it's mean (M_L). The standard deviation (S) is calculated as the square root of the reciprocal of the sum of the weights. U_1 is the combined uncertainty from homogeneity and labs. U_2 is U_1 multiplied by the coverage factor (95 % t-statistic). U_3 is U_2 divided by the square root of the number of determinations (n). Thus:

$$C_{L} = \sqrt{S_{L}^{2} + U_{L}^{2}} \qquad W_{L} = \frac{1}{C_{L}^{2}} \qquad A = \frac{\sum_{i=1}^{n} W_{L} M_{L}}{\sum_{i=1}^{n} W_{L}} \qquad S = \frac{1}{\sqrt{\sum_{i=1}^{n} W_{L}}} U_{1} = \sqrt{H^{2} + S^{2}} \qquad U_{2} = t \times U_{1} \qquad U_{3} = \frac{U_{2}}{\sqrt{n}}$$

All but the final reported values are taken to two significant figures as determined by each quantity's uncertainty estimate. The final reported Uncertainty is U_3 rounded to one significant figure and represents the half width of the 95 % confidence interval for the **Certified** value. The final reported **Certified** value is A rounded to the same decimal place as the Uncertainty. The Uncertainty is a measure of the quality of the **Certified** value.

The Tolerance is a measure of the expected performance of an analysis. This involves further expanding the sample uncertainty to include instrument and operator uncertainty, for those without access to such calculations.

For further information regarding the confidence interval for the certified value see ISO Guide 35:2006 section 6.

BS CD	* Code for analytical method								Trac	e analysi	is liste	ed a	ıs mg/kç	g (pp	m)							
Analysis	*	Ag	*	CI	*	Ga	*	Ge	*	In	,	*	Na	*	Re	*	Ru	*	Sb	Т	*	Se
1	12	0.17	12	0.01	12	19	12	5.0	12	0.10	1	2	0.01	12	0.06	12	10	12	7		12	1.7
2	12	0.19	12	0.02	12	19	12	5.0	12	0.10	1	2	0.01	12	0.06	12	11	12	7.2	$\overline{}$	12	1.7
3	12	0.20	12	0.03	12	20	12	5.1	12	0.10				12	0.07	12	11	12	7.4	\blacksquare	12	1.8
Analysis	*	Sr	*	Та	*	Υ	*	Zn													+	
1	12	0.07	4	54	12	0.01	12	0.15														
2	12	0.07			12	0.01	12	0.16														
3	12	0.12			12	0.02	12	0.17										\Box		\Box		

Analytical Method Codes:

1 Combustion (ASTM E1019)

2 Fusion (ASTM E1019)

3 Spark Atomic Emission

4 ICP Atomic Emission

5 ICP Mass Spectrometry

6 Gravimetric

7 Photometric

13 Titrimetric14 DCP Atomic Emission

8 Flame Atomic Absorption

9 GF Atomic Absorption

15 HG Atomic Fluorescence16 Difference

10 X-Ray Fluorescence11 GD Atomic Emission

12 GD Mass Spectrometry

ICP = Inductively Coupled Plasma

GF = Graphite Furnace

GD = Glow Discharge

DCP = Direct Current Plasma HG = Hydride Generation

Lab Name	Location	Registrar	Accreditation
Brammer Standard Company, Inc.	Houston, TX	A2LA	17025, 17034
NSL Analytical	Cleveland, OH	ANAB	17025
Evans Analytical Group	Liverpool, NY	A2LA	17025
Exova	Glendale Heights, IL	A2LA	17025
Anderson Laboratories, Inc.	Greendale, WI	A2LA	17025
Dirats Laboratories	Westfield,MA	ANAB	17025
National Analysis Center For Iron And Steel	Beijing, China	CNAS	17025
Luvak Inc.	Boylston, MA	PRI	17025
Instytut Metalurgii Zelaza	Gliwice, Poland	PCA	17025
Laboratory Testing, Inc.	Hatfield, PA	PRI	17025
TUV Rheinland Pvt Ltd	Bangalore, India	NABL	17025

A2LA = American Association for Laboratory Accreditation

ANAB = ANSI-ASQ National Accreditation Board

BSI = British Standards Institution

CNAS = China National Accreditation Service

NABL = National Accreditation Board for Testing and Calibration Laboratories

PCA = Polish Center For Accreditation

PRI =Performance Review Institute

SRI = Steel Related Industries

TUV = Technischer Überwachungs-Verein (Technical Inspection Association)

<u>Analysis:</u> Chemical analyses were made on solid pieces and chips prepared by an end mill from representative samples for the certified portion of the lot in accordance with ASTM Standard Practice E1806. The laboratories participating in the testing followed the requirements of ISO Standard 17025.

<u>Traceability:</u> The following Certified Reference Materials were used to validate the analytical data: 13XPH2M, 13XPH4N, 13XPHZE; AR 644, 654, 657, 662, 675, 676, 882, 892, 950, 956, 1647, 1648, 1652, 1653; BAS 431, 464/1, 475; BS HON-U, 17-4PHA, 30D, 56H, 75G, 88E, 179A, 179B, 180B, 184, 185, 187D, 303, 2205; ECRM 151-1; IARM 2C, 3B, 4C, 5F, 16C, 21C, 22B, 212B, 212C, 212D, 239A, 239B, 289A, 301A, 302A; ICRM LG58; IMZ 163A, 163; JK 37; LECO 501-320, 501-504, 501-644, 501-646, 501-674, 501-676, 502-195, 502-868, 502-887, 502-904, 502-916, 502-928; NCS NS 11019, NS 21006; SRM C2401, 10G, 15G, 55D, 101A, 101C, 101G, 160B, 339, 345, 345A, 361, 362, 363, 369, 1155A

<u>Homogeneity:</u> This Certified Reference Material (CRM) was tested for homogeneity using ASTM Standard Method E826 and found acceptable. It was also examined by spark atomic emission spectrometry and found to be compatible with the following Reference Materials — BAS 475; BS HON-U, 88E, 179B, 184, 185; ECRM 151-1; IARM 289A; ICRM LG58; IMZ 153A; LECO 501-676, 502-887; NCS NS 11019, NS 21006; SRM C2401, 101G, 339.

<u>Validity statement:</u> ISO Guide 31 states that the certification should contain an expiration date for all materials where instability has been demonstrated or is considered possible, after which the certified value is no longer guaranteed by the certifying body. The certification of BS CD4MCU-A-062019 is valid indefinitely. The certification is nullified if this CRM is damaged, contaminated, or otherwise modified.

Storage: This CRM must be stored in a cool, dry, non-corrosive environment.

Source: The bar stock for this CRM was produced by Instytut Metalurgii Zelaza im; Gliwice, Poland.

<u>Form:</u> This CRM is machined in the form of a disc, approximately 44 mm in diameter and 19 mm thick by Brammer Standard Company, Inc.

<u>Use:</u> This CRM is intended for use in spark atomic emission, glow discharge, and x-ray spectrometric methods of analysis. Refer to ISO Guide 33 for information about the use of Certified Reference Materials.

<u>Certified Area:</u> The entire depth of the CRM may be used.

Caution: As with any bar material, avoid spark atomic emission spectrometric burns in the center of the CRM (5 mm radius), as some segregation may be present.

<u>Sample Preparation:</u> For best analytical results, use the same method for preparing the analytical surface on all reference materials as used for production specimens. Avoid overheating the sample during surface preparation.

Caution: CRM contains significant insoluble soft metal inclusions. Surface smearing may occur. Spark atomic emission spectrometers may require extended preburns to compensate.

<u>Certificate Number:</u> The unique identification number for this certificate of analysis is CD4MCU-A-062019. You may obtain information on revisions of certificates from the internet at <u>www.brammerstandard.com</u>.

<u>Safety Notice:</u> A Safety Data Sheet (SDS) is not required for this material. This material will not release or otherwise result in exposure to a hazardous chemical, under normal conditions of use. Inquiries concerning this Reference Material should be directed to:

Brammer Standard Co., Inc. Phone: (281) 440-9396Web: <u>www.brammerstandard.com</u>

14603 Benfer Road

Houston, Texas 77069-2895 USA Fax: (281) 440-4432 Email: contact@brammerstandard.com

Brammer Standard Company, Inc., is accredited by the American Association For Laboratory Accreditation (A2LA) to ISO Standard 17034 as a Reference Material Producer for the production of Certified Reference Materials and Reference Materials (Certificate Number 656.02)

Brammer Standard Company's Chemical Laboratory is accredited by A2LA to ISO Standard 17025. (Certificate Number 656.01)

By Certificate Number 10539, the Quality System of Brammer Standard Company, Inc., is registered to ISO 9001 by National Quality Assurance (NQA), U.S.A.

The scopes of accreditation are listed on the website: www.brammerstandard.com

References:

Versions used were those available at the time of testing and characterization

E826 Standard Practice for Testing Homogeneity of a Metal Lot or Batch in Solid Form by Spark Atomic Emission Spectrometry

Specifornelly

E1019 Standard Test Methods for Determination of Carbon, Sulfur, Nitrogen, and Oxygen in Steel, Iron, Nickel, and

Cobalt Alloys by Various Combustion and Fusion Techniques

E1806 Standard Practice for Sampling Steel and Iron for Determination of Chemical Composition

ISO Standard 17025:2005 General requirements for the competence of testing and calibration laboratories
ISO Standard 9001:2015 Quality Management Systems - Requirements
ISO Guide 30:2015 Terms and definitions used in connection with reference materials + 2008 amendment
ISO Guide 31:2015 Reference materials - Contents of certificates and labels
ISO Guide 33:2015 Uses of certified reference materials
ISO Standard 17034:2016 General requirements for the competence of reference material producers
ISO Guide 35:2006 Reference Materials - General and statistical principles for certification
ASTM documents available from ASTM, 100 Barr Harbor Dr., West Conshohocken, PA 19428. ISO Guides and Standards available from Global Engineering - www.global.ihs.com
Other useful documents available from NIST, U.S. Department of Commerce, Gaithersburg, MD 20899.
NIST Special Publication 260-100, Handbook for SRM Users
NIST Special Publication 829, Use of NIST Standard Reference Materials for Decisions on Performance of Analytical Chemical Methods and Laboratories
Certified by: on June 20, 2019.
Beau R. Brammer
President